

# **A 80GHz Voltage Controlled Oscillator With a Negative Varactor in 90nm CMOS Technology**

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# Outline

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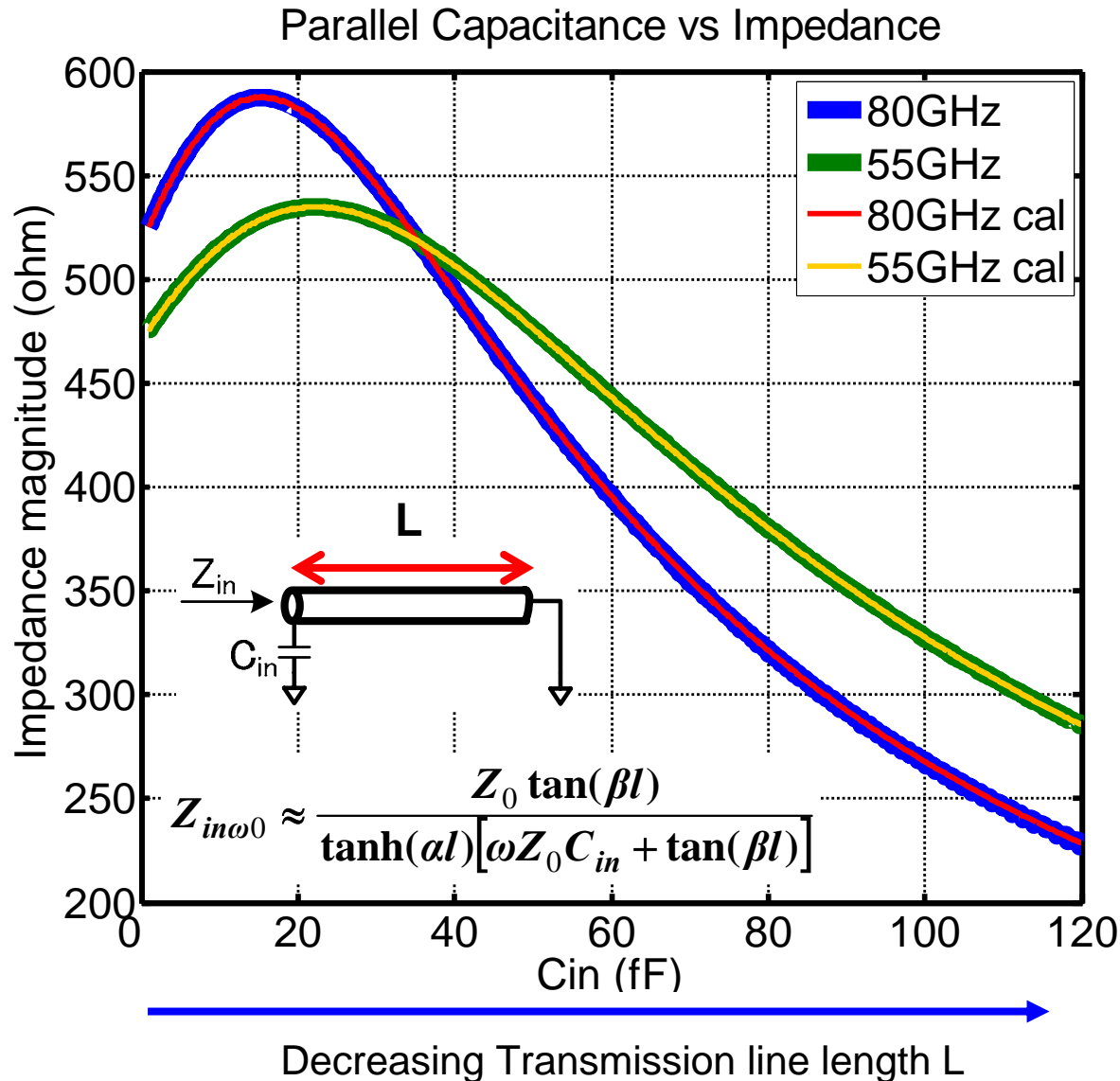
- **Background**
- **Negative Equivalent Capacitance**
- **Schematic**
- **Measurement results**

# Background

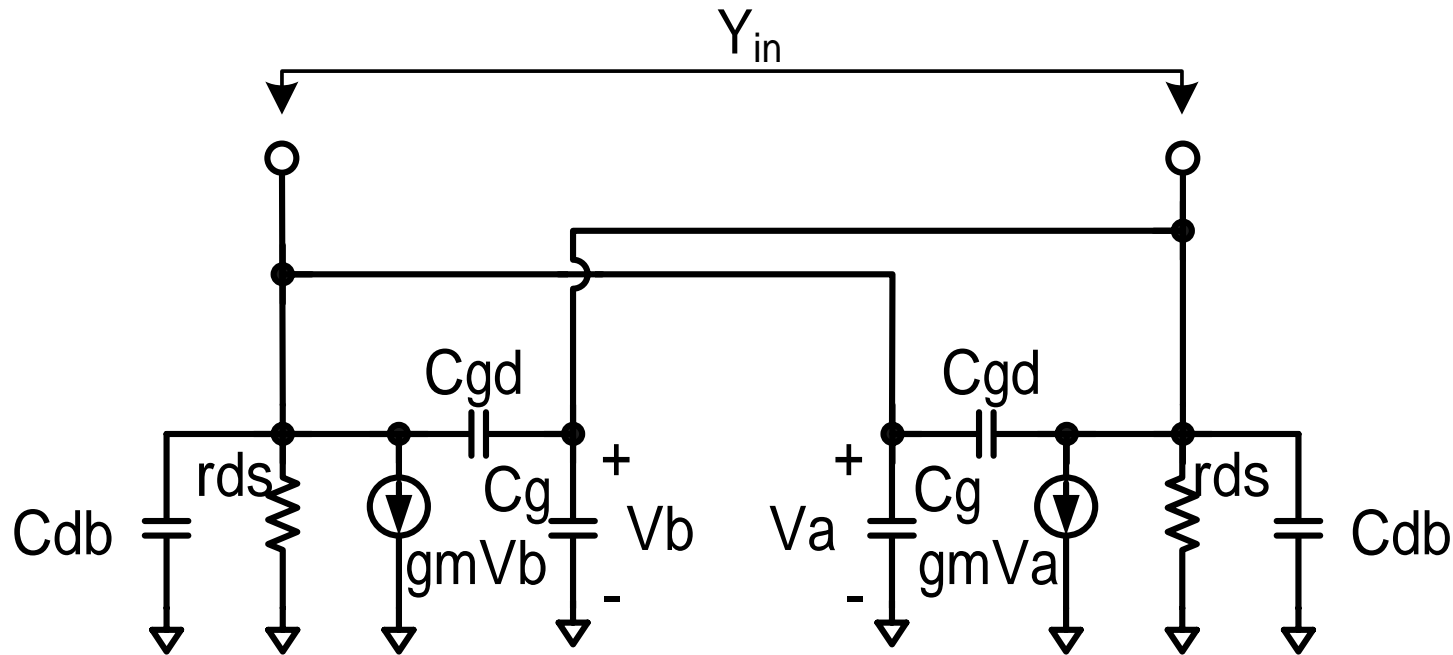
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- **Challenges of mm-Wave VCOs**
  - **Differential pair, varactor and switches increase loading capacitance**
  - **Input impedance decreases with loading capacitance**
  - **Increase of tail current has diminishing returns in producing negative resistance**

# Imp. at fo of Shorted T-line w/ Cap.



# Impedance of Diff Pair

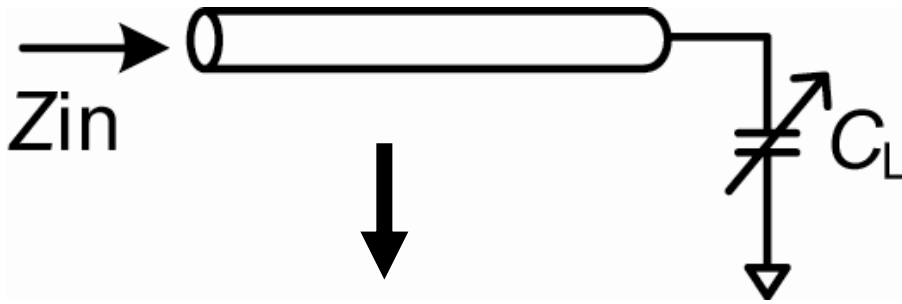


$$Y_{in} = \frac{1}{2 \cdot r_{ds}} - \frac{g_m}{2} + j \left( \frac{\omega \cdot C_{db}}{2} + 2 \cdot \omega \cdot C_{gd} + \frac{\omega \cdot C_g}{2} \right)$$

Increasing current increases  $g_m$ , and also  $1/(2 \cdot r_{ds})$   
 There is a limit on how much current can be increased

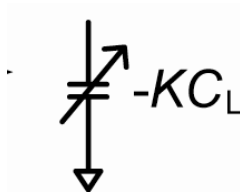
# Negative Varactor Capacitance

Condition for negative cap.



$$Z_0 \omega C_L \tan \beta l > 1 \cap \frac{\tan \beta l}{Z_0 \omega C_L} > -1$$

$$\frac{\tan \beta l}{Z_0 \omega C_L} < -1 \cap Z_0 \omega C_L \tan \beta l < 1$$

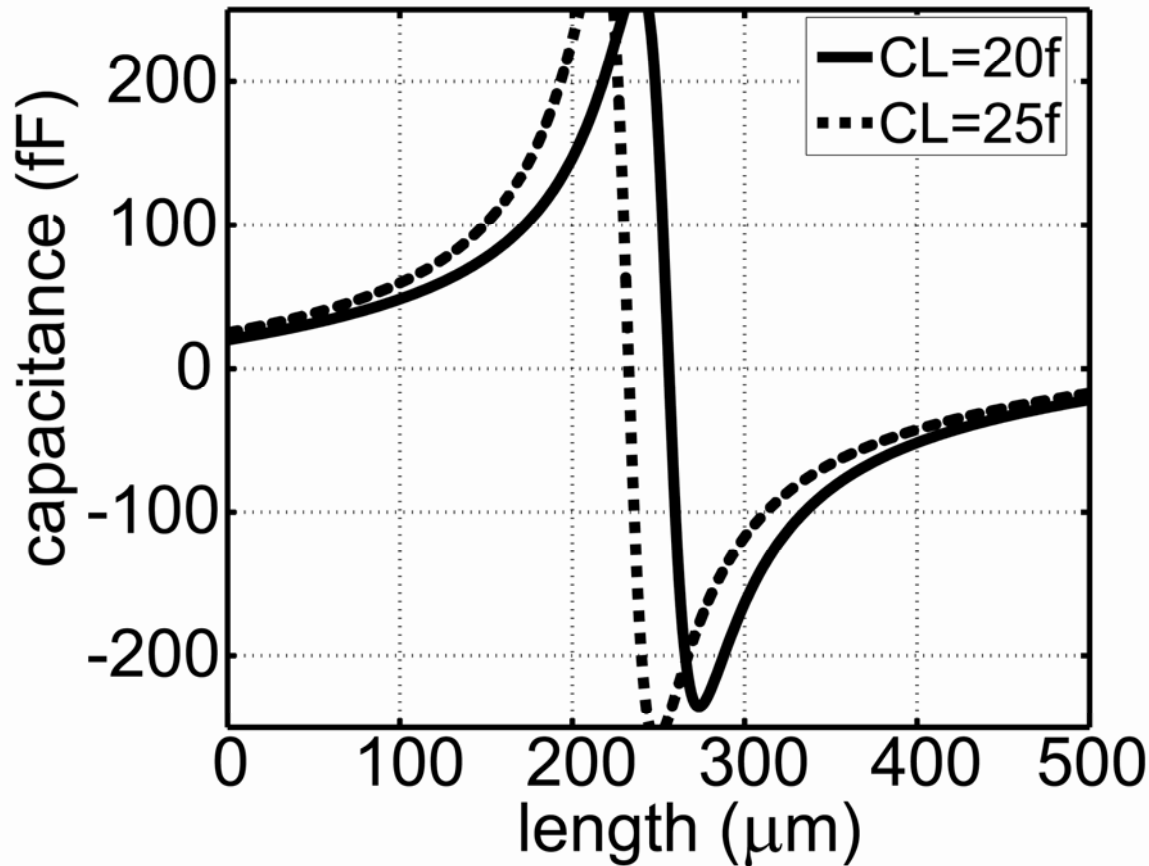


Equivalent input capacitance

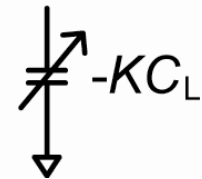
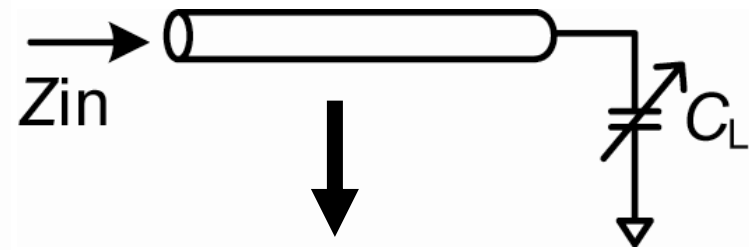
$$C_{eq} = \text{Im} \left( \frac{Z_0 \omega C_L + \tan \beta l}{\omega Z_0 (1 - Z_0 \omega C_L \tan \beta l)} \right)$$

# Equivalent Capacitance Plot

Impedance vs length of Tline



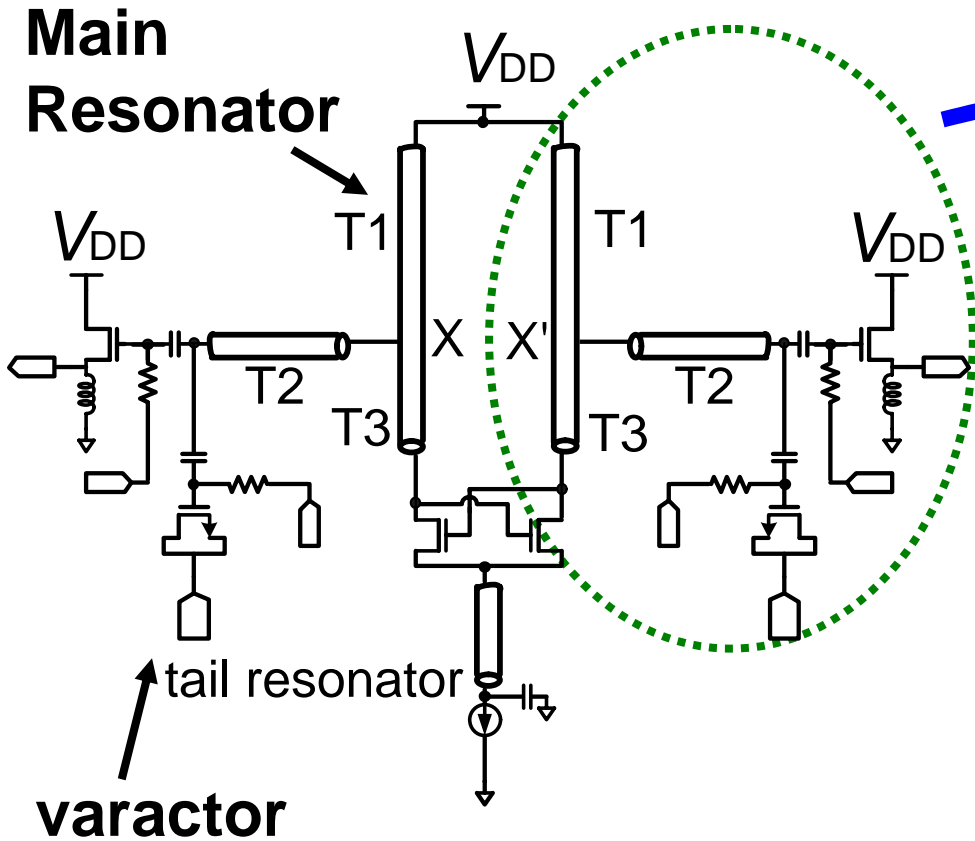
Transmission line  
with loaded  
capacitance



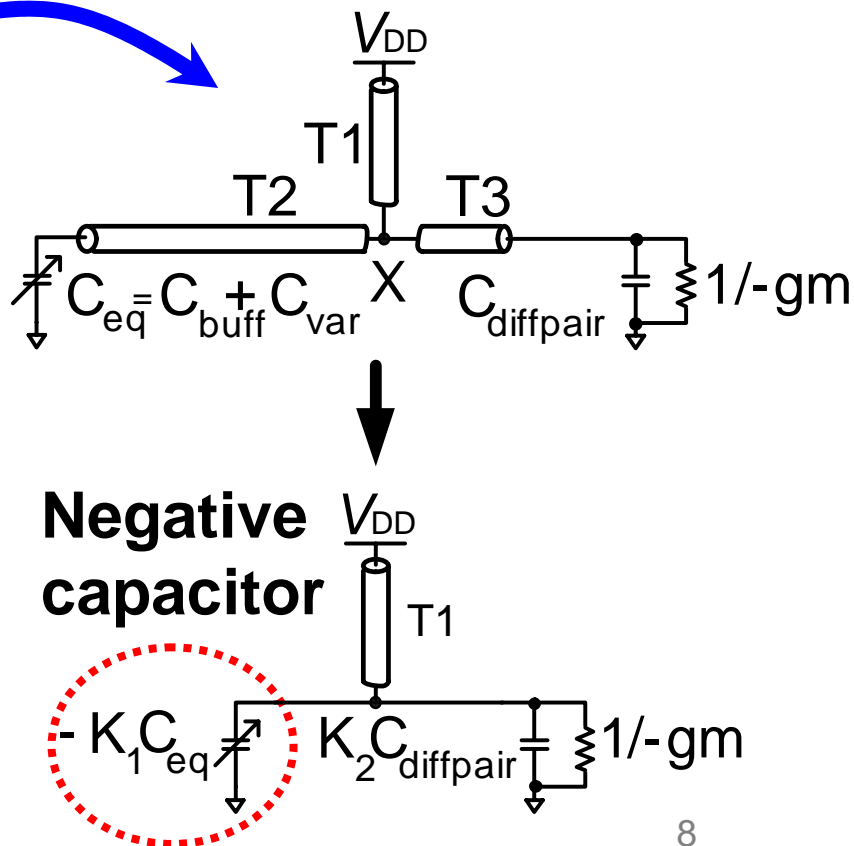
Equivalent capacitance

# Equivalent Circuit

Schematic of 80GHz VCO



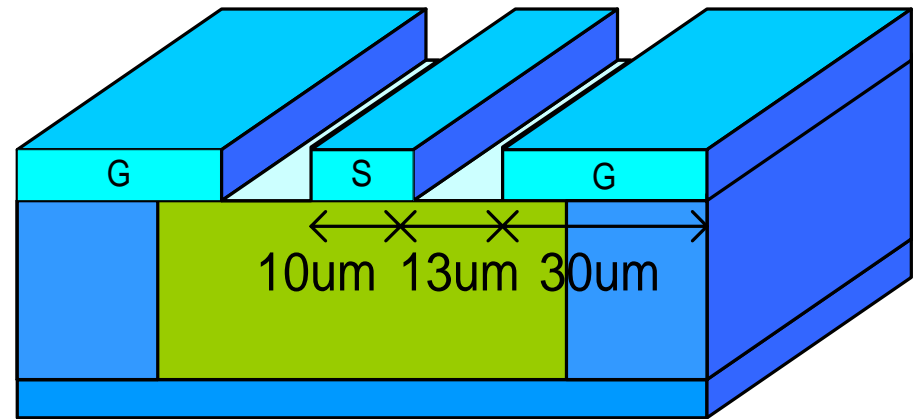
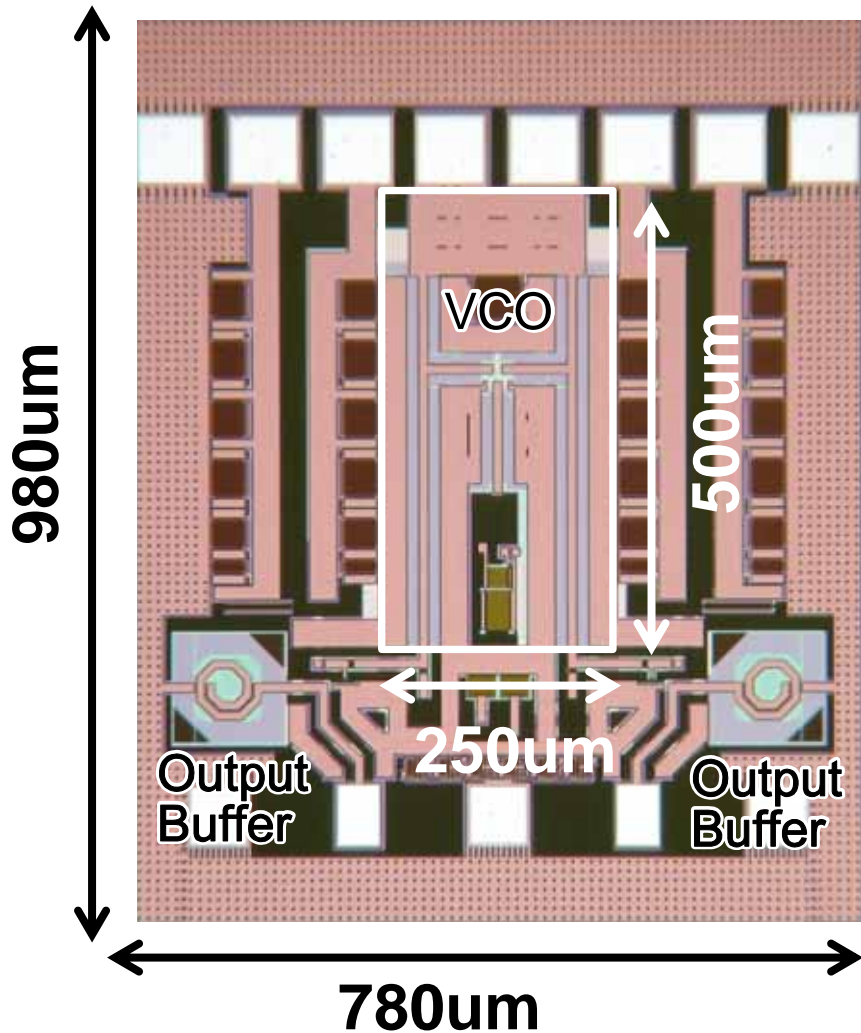
Equivalent circuit of 80GHz VCO





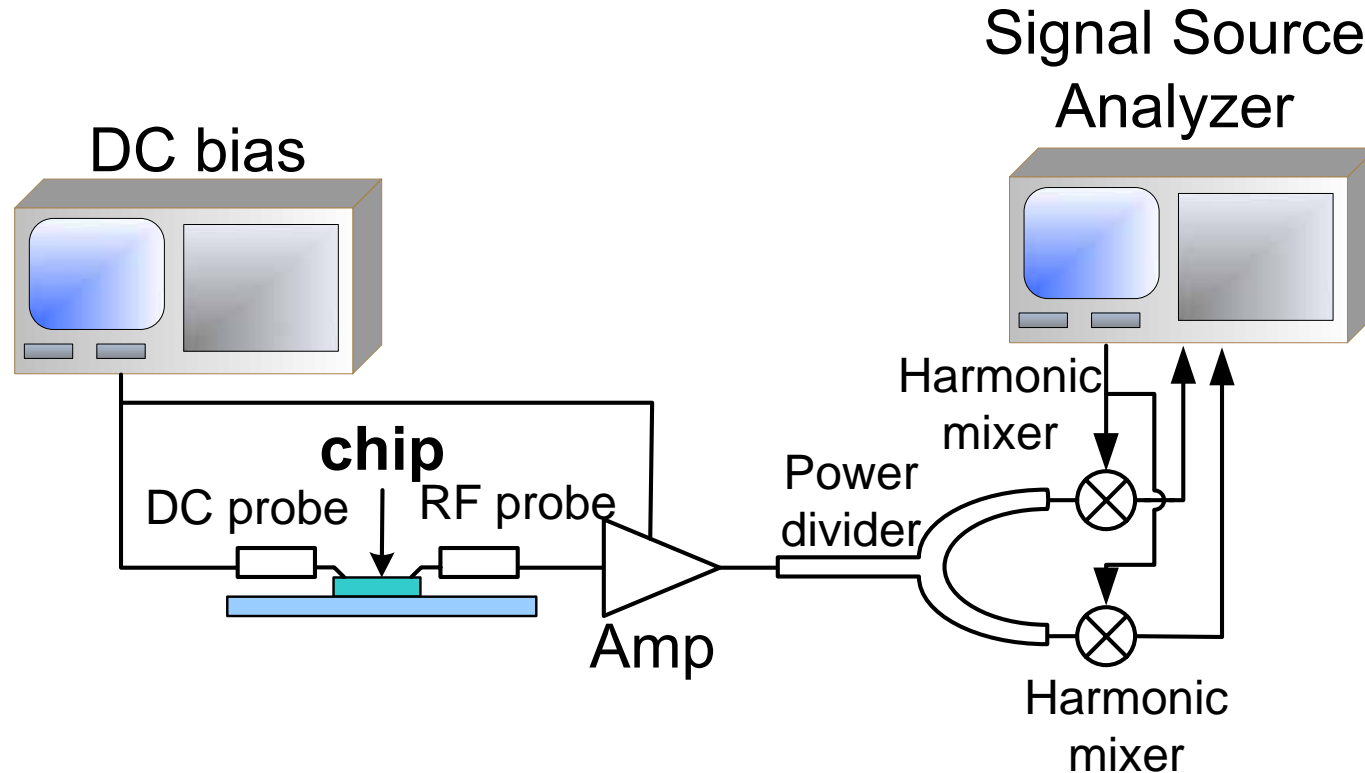
# Chip Photo

Chip Photo of mm-Wave VCO



**Simulated  $Q > 20$**

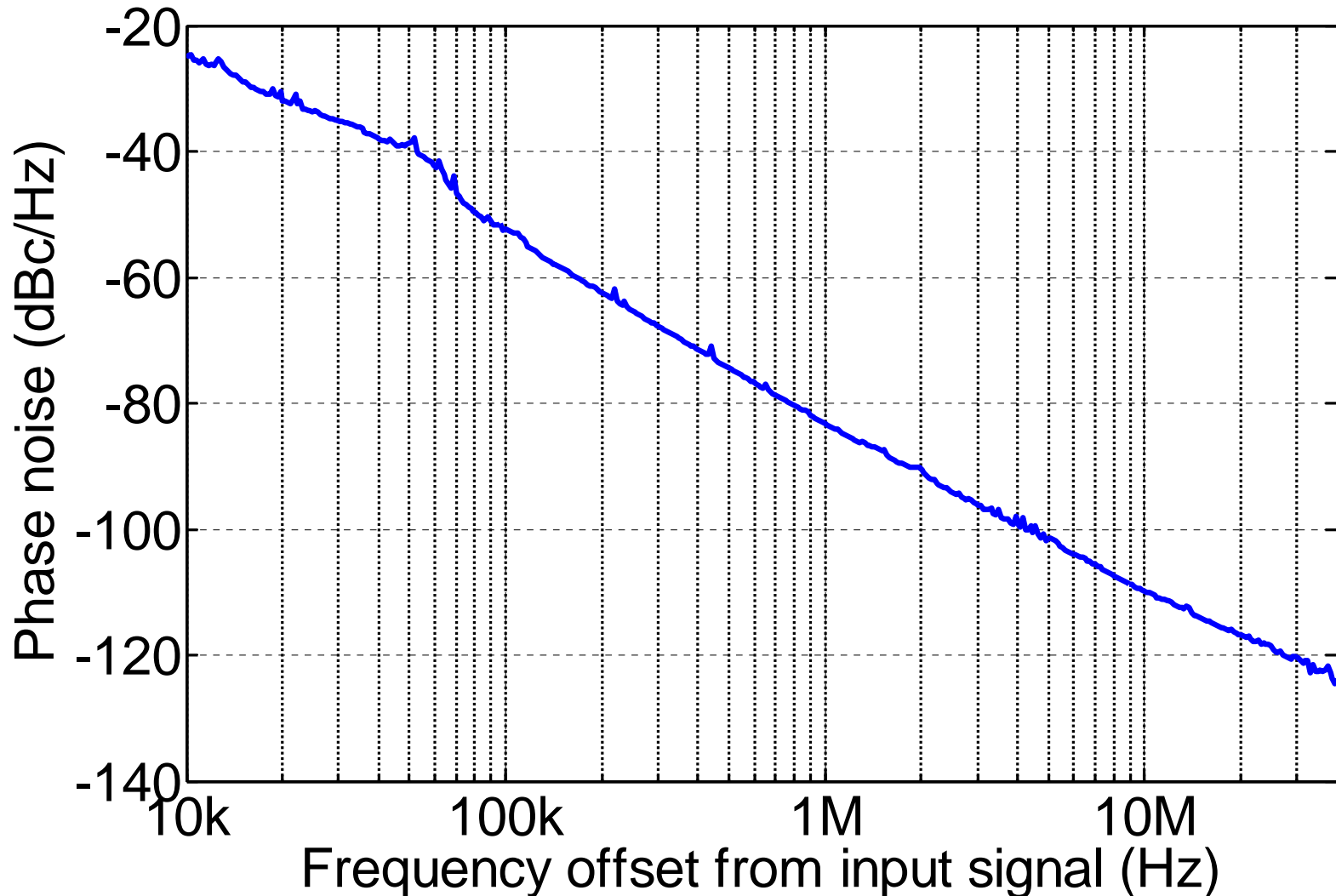
# Measurement Setup



**Harmonic mixer – up to 60dB loss**  
**Amp – Max 30dB gain**

# Measured Phase noise

Phase Noise plot



# VCO Measurement Summary

	This	[1]	[2]	[3]
f <sub>0</sub> (GHz)	83GHz	90.3	70.2	76.5
FTR (GHz)	0.68	2.9	6.68	5.5
PN (dBc/Hz)	-110@10MHz	-95@1MHz	-106@10MHz	-111@10MHz
P <sub>diss</sub> (mW)	13	57.7	5.4	13.58
FOM	-177	-176	-175.7	-176
Power supply	1.2V	1.2v	1.2	0.7V
Technology	90nm CMOS	65nm CMOS	65nm SOI	90nm CMOS

[1] Laskin, ISSCC08

[2] Kim, ISSCC07

[3] Ishibashi, VLSI 2007

# Summary and Conclusion

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- **Decreased tank impedance due to tank capacitance at high frequency limit the operation of oscillators at high frequencies**
- **Increasing the current and gm is limited by the decreased output impedance due to the drain source resistance**
- **Impedance transformation can help to create a negative capacitance to cancel out the parasitic capacitance of the tank, increasing oscillation frequency**